IN THE CLAIMS

A listing of the claims presented in this patent application appears below. This listing replaces all prior versions and listing of claims in this patent application.

- 1. (Original) A bonding wire comprising a core and a coating layer formed on the core, wherein the coating layer is formed from a metal having a higher melting point than the core, and the wet contact angle with the coating layer when the core is melted is not smaller than 20 degrees.
- 2. (Original) A bonding wire comprising a core composed mainly of copper and a coating layer formed on the core, wherein the coating layer is formed from an oxidation resistant metal having a higher melting point than the core, and wherein when the bonding wire is hung down with its end touching a horizontal surface, and is cut at a point 15 cm above the end and thus let drop onto the horizontal surface, the curvature radius of the formed arc is 35 mm or larger.
- 3. (Original) The bonding wire according to claim 2, wherein the curvature radius of the formed arc is 40 mm or larger.
- 4. (Original) A bonding wire comprising a core composed mainly of copper and a coating layer formed on the core, wherein the coating layer is formed from an oxidation resistant metal having a higher melting point than the core, and wherein the 0.2% yield strength is not smaller than 0.115 mN/μm² but not greater than 0.165 mN/μm².
- 5. (Original) The bonding wire according to claim 4, wherein the 0.2% yield strength is not smaller than 0.125 mN/ μ m² but not greater than 0.155 mN/ μ m².

- 6. (Original) A bonding wire comprising a core and a coating layer formed on the core, wherein the coating layer is formed from a metal having a higher melting point than the core, and wherein the Vickers hardness of the coating layer is 300 or lower.
- 7. (Original) The bonding wire according to claim 1 or 6, wherein the core material is composed mainly of copper.
- 8. (Currently Amended) The bonding wire according to any one of claims 2—5 and 7 claim 2 or 4, wherein the coating layer is formed from a metal whose melting point is at least 200°C higher than that of copper.
- 9. (Currently Amended) The bonding wire according to any one of elaims 2-5, 7 and 8 claims 2, 4 and 7, wherein the elongation per unit cross sectional area is 0.021% / μm^2 or more.
- 10. (Currently Amended) The bonding wire according to any one of claims 2 5 and 7 claim 2 or 4, wherein the core contains other elements than copper in a total amount not smaller than 0.001 weight percent but not larger than 1 weight percent relative to the weight of the core.
- 11. (Original) The bonding wire according to claim 1 or 6, wherein the core material is composed mainly of silver.
- 12. (Original) The bonding wire according to claim 6, which has a coating layer B whose Vickers hardness is 150 or less, outside of the coating layer, as the utmost layer.
- 13. (Original) The bonding wire according to claim 12, wherein the material for the coating layer B is gold.

- 14. (Currently Amended) The bonding wire according to claim 12 or 13, wherein the thickness of the coating layer B is smaller than that of the coating layer and not larger than 0.002 times the wire diameter.
- 15. (Currently Amended) The bonding wire according to any one of elaims 1—14 claims 1, 2, 4 and 6, wherein the coating layer is formed from a metal composed mainly of at least one element selected from the group consisting of palladium, platinum, and nickel.
- 16. (Original) The bonding wire according to claim 15, wherein the coating layer is formed from palladium.
- 17. The bonding wire according to any one of elaims 1 16 claims 1, 2, 4 and 6, wherein the thickness of the coating layer falls within the range satisfying as $0.007 \le Y \le 0.05$, where Y = (cross sectional area of coating layer / cross sectional area of core) in the cross section when the wire is cut vertically.
- 18. (Currently Amended) The bonding wire according to any one of elaims 1 17 claims 1, 2, 4 and 6, wherein a different metal layer is provided between the core and the coating layer.
- 19. (Currently Amended) An integrated circuit device that is produced by using the bonding wire according to any one of claims 1—18 claims 1, 2, 4, 6 and 15.